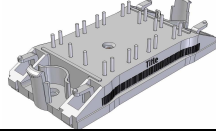
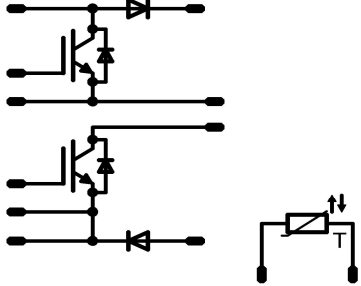




flowBOOST0	600V/75A
<div style="border: 1px solid black; padding: 5px; margin-bottom: 5px;"> <p style="text-align: center; background-color: #000080; color: white; margin: 0;">Features</p> <ul style="list-style-type: none"> Symmetric boost Clip-In PCB mounting Low Inductance Layout </div> <div style="border: 1px solid black; padding: 5px; margin-bottom: 5px;"> <p style="text-align: center; background-color: #000080; color: white; margin: 0;">Target Applications</p> <ul style="list-style-type: none"> UPS </div> <div style="border: 1px solid black; padding: 5px;"> <p style="text-align: center; background-color: #000080; color: white; margin: 0;">Types</p> <ul style="list-style-type: none"> 10-FZ06NBA075SA-P916L33 </div>	<div style="border: 1px solid black; padding: 5px; margin-bottom: 5px;"> <p style="text-align: center; background-color: #000080; color: white; margin: 0;">flow0 housing</p>  </div> <div style="border: 1px solid black; padding: 5px;"> <p style="text-align: center; background-color: #000080; color: white; margin: 0;">Schematic</p>  </div>

Maximum Ratings

T_j=25°C, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
Input Boost IGBT				
Collector-emitter break down voltage	V _{CE}		600	V
DC collector current	I _C	T _j =T _{jmax} T _h =80°C T _c =80°C	56 74	A
Repetitive peak collector current	I _{Cpulse}	t _p limited by T _{jmax}	225	A
Power dissipation per IGBT	P _{tot}	T _j =T _{jmax} T _h =80°C T _c =80°C	93 141	W
Gate-emitter peak voltage	V _{GE}		±20	V
Short circuit ratings	t _{SC} V _{CC}	T _j ≤150°C V _{GE} =15V	6 360	μs V
Maximum Junction Temperature	T _{jmax}		175	°C
Input Boost Inverse Diode				
Peak Repetitive Reverse Voltage	V _{RRM}	T _j =25°C	600	V
DC forward current	I _F	T _j =T _{jmax} T _h =80°C T _c =80°C	33 44	A
Repetitive peak forward current	I _{FRM}	t _p limited by T _{jmax}	90	A
Power dissipation per Diode	P _{tot}	T _j =T _{jmax} T _h =80°C T _c =80°C	53 80	W
Maximum Junction Temperature	T _{jmax}		175	°C

**Maximum Ratings**T_j=25°C, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
-----------	--------	-----------	-------	------

Input Boost FWD

Peak Repetitive Reverse Voltage	V _{RRM}	T _j =25°C	600	V	
DC forward current	I _F	T _j =T _{jmax}	T _h =80°C	63	A
			T _c =80°C	83	
Repetitive peak forward current	I _{FRM}	t _p limited by T _{jmax}	150	A	
Power dissipation	P _{tot}	T _j =T _{jmax}	T _h =80°C	86	W
			T _c =80°C	130	
Maximum Junction Temperature	T _{jmax}		175	°C	

Thermal Properties

Storage temperature	T _{stg}		-40...+125	°C
Operation temperature under switching condition	T _{op}		-40...+(T _{jmax} - 25)	°C

Insulation Properties

Insulation voltage	V _{is}	t=2s	DC voltage	4000	V
Creepage distance				min 12,7	mm
Clearance				min 12,7	mm

Characteristic Values

Parameter	Symbol	Conditions					Value			Unit
		$V_{GE}[V]$ or $V_{GS}[V]$	$V_r[V]$ or $V_{CE}[V]$ or $V_{DS}[V]$	$I_c[A]$ or $I_F[A]$ or $I_b[A]$	T_j	Min	Typ	Max		
Input Boost IGBT										
Gate emitter threshold voltage	$V_{GE(th)}$	$V_{CE}=V_{GE}$			0,0012	$T_j=25^\circ C$ $T_j=150^\circ C$	5	5,8	6,5	V
Collector-emitter saturation voltage	$V_{CE(sat)}$		15		75	$T_j=25^\circ C$ $T_j=150^\circ C$	1	1,63 1,86	2,1	V
Collector-emitter cut-off	I_{CES}		0	600		$T_j=25^\circ C$ $T_j=150^\circ C$			0,2	mA
Gate-emitter leakage current	I_{GES}		20	0		$T_j=25^\circ C$ $T_j=150^\circ C$			650	nA
Integrated Gate resistor	R_{gint}							none		Ω
Turn-on delay time	$t_{d(on)}$	Rgoff=8 Ω Rgon=8 Ω	± 15	300	75	$T_j=25^\circ C$		151		ns
Rise time	t_r					$T_j=150^\circ C$		154		
Turn-off delay time	$t_{d(off)}$					$T_j=25^\circ C$		20		
Fall time	t_f					$T_j=150^\circ C$		24		
Turn-on energy loss per pulse	E_{on}					$T_j=25^\circ C$		209		
Turn-off energy loss per pulse	E_{off}					$T_j=150^\circ C$		233		
Input capacitance	C_{ies}									
Output capacitance	C_{oss}	f=1MHz	0	25		$T_j=25^\circ C$		288		
Reverse transfer capacitance	C_{rss}							137		
Gate charge	Q_{Gate}	f=1MHz	0	25		$T_j=25^\circ C$		470		nC
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness $\leq 50\mu m$ $\lambda = 1 W/mK$						1,02		K/W
Input Boost Inverse Diode										
Diode forward voltage	V_F				10	$T_j=25^\circ C$ $T_j=125^\circ C$	1	1,63 1,56	2,05	V
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness $\leq 50\mu m$ $\lambda = 1 W/mK$						1,8		K/W
Input Boost FWD										
Forward voltage	V_F				75	$T_j=25^\circ C$ $T_j=125^\circ C$	1	1,49 1,46	2	V
Reverse leakage current	I_{rm}			600		$T_j=25^\circ C$ $T_j=125^\circ C$			30	μA
Peak recovery current	I_{RRM}	Rgoff=8 Ω	± 15	300	75	$T_j=25^\circ C$		70		A
Reverse recovery time	t_{rr}					$T_j=125^\circ C$		86		
Reverse recovery charge	Q_{rr}					$T_j=25^\circ C$		117		
Reverse recovered energy	E_{rec}					$T_j=125^\circ C$		152		
Peak rate of fall of recovery current	$di(rec)max/dt$					$T_j=25^\circ C$		3,07		
						$T_j=125^\circ C$		6,19		
						$T_j=25^\circ C$		0,61		
		$T_j=125^\circ C$		1,33						
Thermal resistance chip to heatsink	R_{thJH}	Thermal grease thickness $\leq 50\mu m$ $\lambda = 1 W/mK$						1,11		K/W
Thermistor										
Rated resistance	R					$T_j=25^\circ C$		22000		Ω
Deviation of R100	$\Delta_{R/R}$	R100=1486 Ω				$T_j=100^\circ C$	-5		+5	%
Power dissipation	P					$T_j=25^\circ C$		200		mW
Power dissipation constant						$T_j=25^\circ C$		2		mW/K
B-value	$B_{(25/50)}$	Tol. $\pm 3\%$				$T_j=25^\circ C$		3950		K
B-value	$B_{(25/100)}$	Tol. $\pm 3\%$				$T_j=25^\circ C$		3996		K
Vincotech NTC Reference									B	

* see details on Thermistor charts on Figure 2.

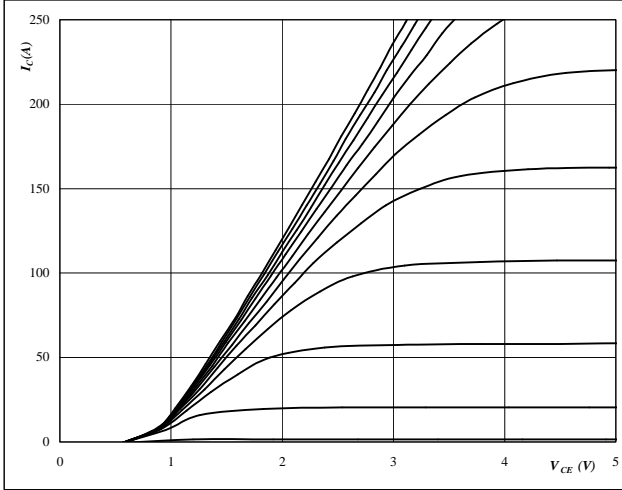


INPUT BOOST

Figure 1 BOOST IGBT

Typical output characteristics

$I_C = f(V_{CE})$



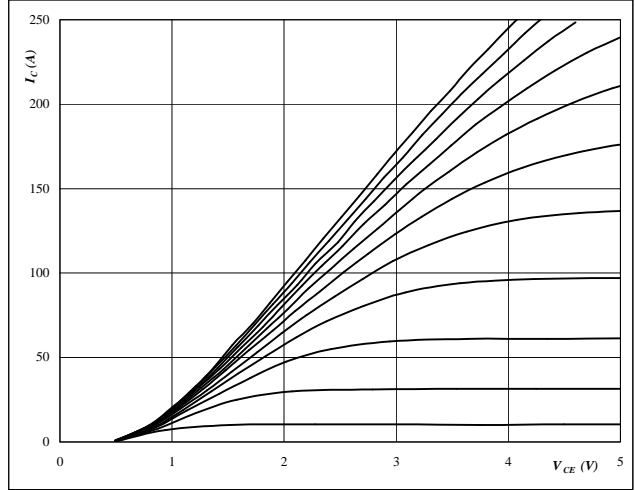
At

$t_p = 250 \mu s$
 $T_j = 25 \text{ }^\circ C$
 V_{GE} from 7 V to 17 V in steps of 1 V

Figure 2 BOOST IGBT

Typical output characteristics

$I_C = f(V_{CE})$



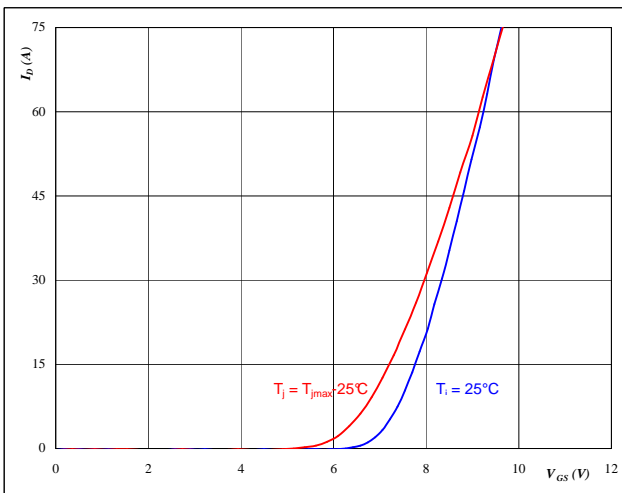
At

$t_p = 250 \mu s$
 $T_j = 150 \text{ }^\circ C$
 V_{GE} from 7 V to 17 V in steps of 1 V

Figure 3 BOOST IGBT

Typical transfer characteristics

$I_D = f(V_{GE})$



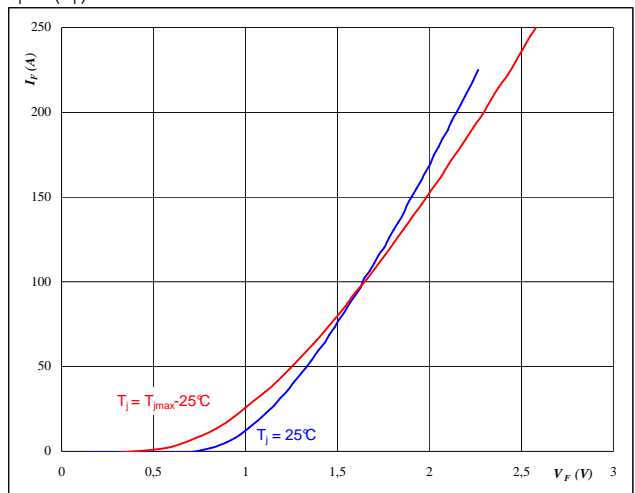
At

$t_p = 250 \mu s$
 $V_{CE} = 10 V$

Figure 4 BOOST FWD

Typical diode forward current as a function of forward voltage

$I_F = f(V_F)$



At

$t_p = 250 \mu s$

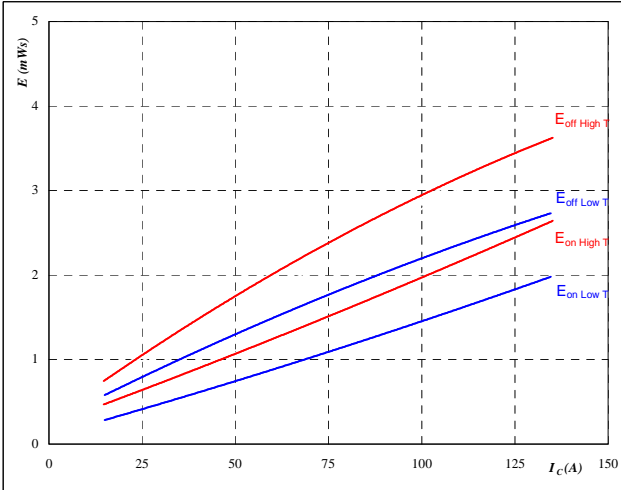


INPUT BOOST

Figure 5 BOOST IGBT

Typical switching energy losses as a function of collector current

$E = f(I_C)$



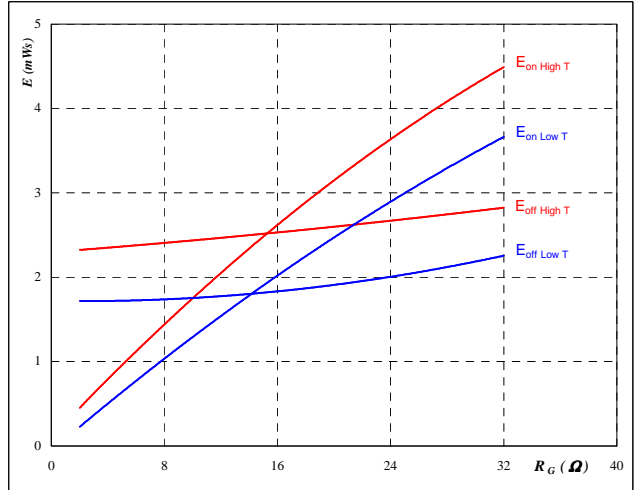
With an inductive load at

- $T_j = 25/150 \text{ } ^\circ\text{C}$
- $V_{CE} = 300 \text{ V}$
- $V_{GE} = \pm 15 \text{ V}$
- $R_{gon} = 8 \text{ } \Omega$
- $R_{goff} = 8 \text{ } \Omega$

Figure 6 BOOST IGBT

Typical switching energy losses as a function of gate resistor

$E = f(R_G)$



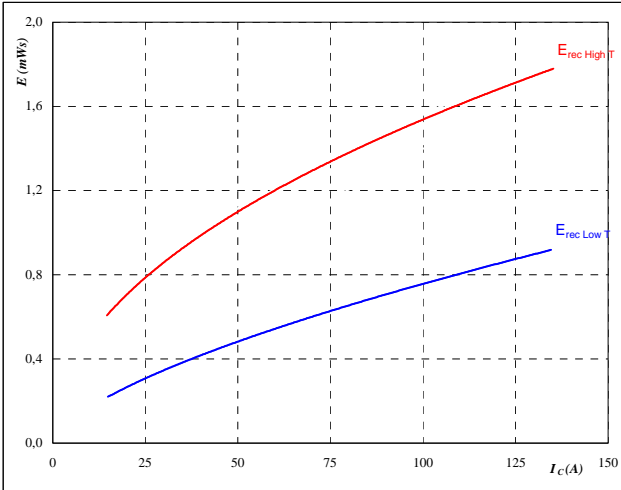
With an inductive load at

- $T_j = 25/150 \text{ } ^\circ\text{C}$
- $V_{CE} = 300 \text{ V}$
- $V_{GE} = \pm 15 \text{ V}$
- $I_C = 75 \text{ A}$

Figure 7 BOOST IGBT

Typical reverse recovery energy loss as a function of collector current

$E_{rec} = f(I_C)$



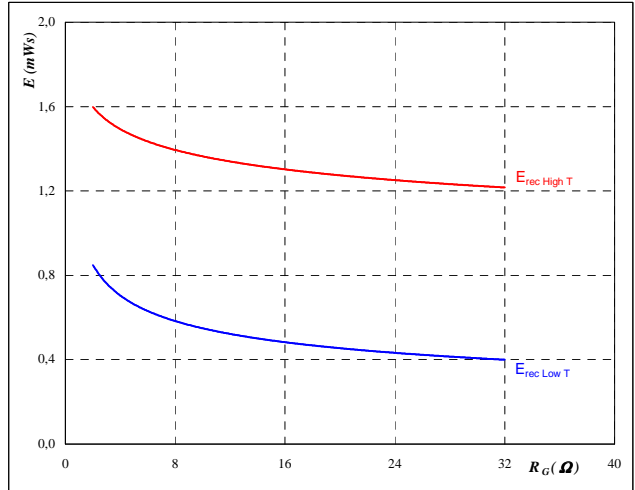
With an inductive load at

- $T_j = 25/150 \text{ } ^\circ\text{C}$
- $V_{CE} = 300 \text{ V}$
- $V_{GE} = \pm 15 \text{ V}$
- $R_{gon} = 8 \text{ } \Omega$
- $R_{goff} = 8 \text{ } \Omega$

Figure 8 BOOST IGBT

Typical reverse recovery energy loss as a function of gate resistor

$E_{rec} = f(R_G)$



With an inductive load at

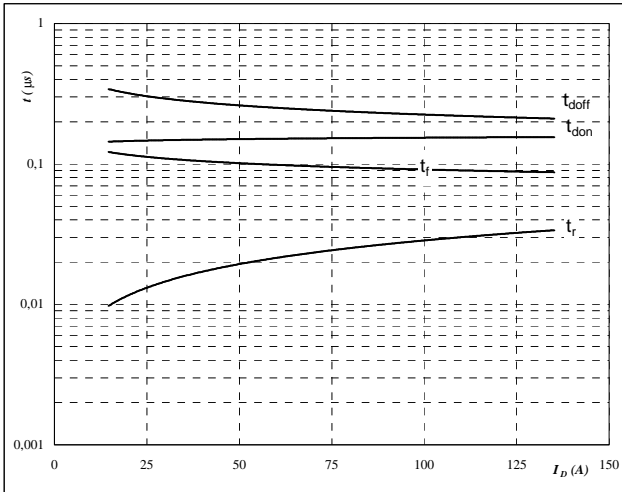
- $T_j = 25/150 \text{ } ^\circ\text{C}$
- $V_{CE} = 300 \text{ V}$
- $V_{GE} = \pm 15 \text{ V}$
- $I_C = 75 \text{ A}$



INPUT BOOST

Figure 9 BOOST IGBT

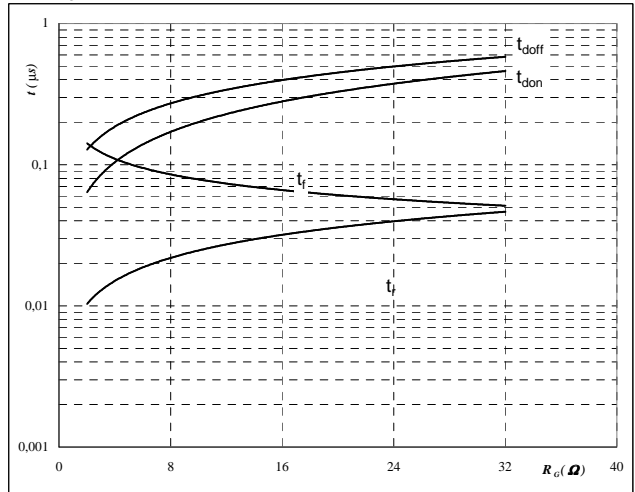
Typical switching times as a function of collector current
 $t = f(I_D)$



With an inductive load at
 $T_j = 150 \text{ } ^\circ\text{C}$
 $V_{CE} = 300 \text{ V}$
 $V_{GE} = \pm 15 \text{ V}$
 $R_{gon} = 8 \text{ } \Omega$
 $R_{goff} = 8,015 \text{ } \Omega$

Figure 10 BOOST IGBT

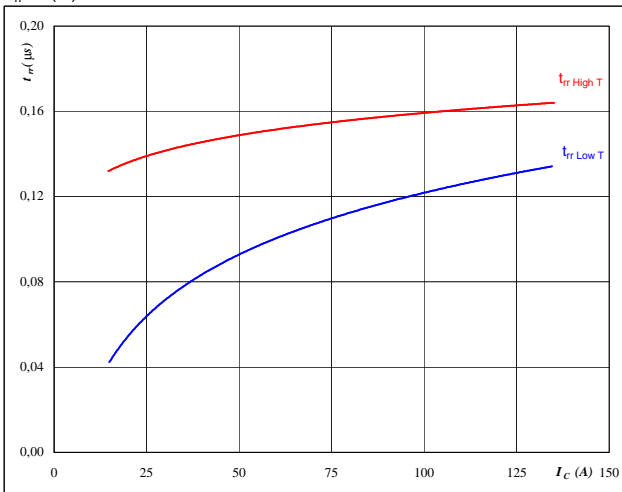
Typical switching times as a function of gate resistor
 $t = f(R_G)$



With an inductive load at
 $T_j = 150 \text{ } ^\circ\text{C}$
 $V_{CE} = 300 \text{ V}$
 $V_{GE} = \pm 15 \text{ V}$
 $I_C = 75 \text{ A}$

Figure 11 BOOST FWD

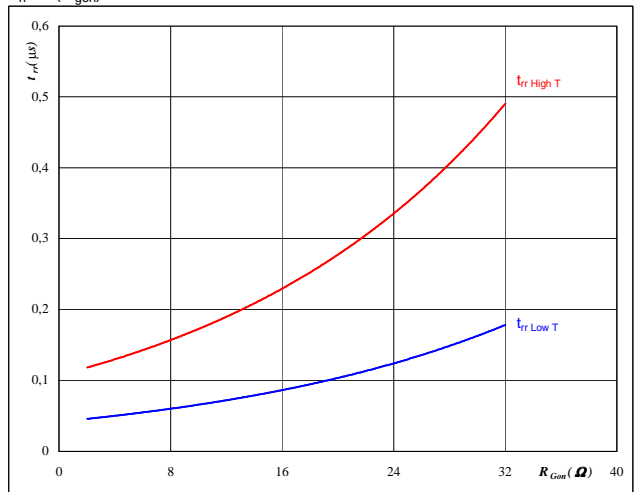
Typical reverse recovery time as a function of collector current
 $t_{rr} = f(I_C)$



At
 $T_j = 25/150 \text{ } ^\circ\text{C}$
 $V_{CE} = 300 \text{ V}$
 $V_{GE} = \pm 15 \text{ V}$
 $R_{gon} = 8 \text{ } \Omega$

Figure 12 BOOST FWD

Typical reverse recovery time as a function of IGBT turn on gate resistor
 $t_{rr} = f(R_{Gon})$



At
 $T_j = 25/150 \text{ } ^\circ\text{C}$
 $V_R = 300 \text{ V}$
 $I_F = 75 \text{ A}$
 $V_{GE} = \pm 15 \text{ V}$

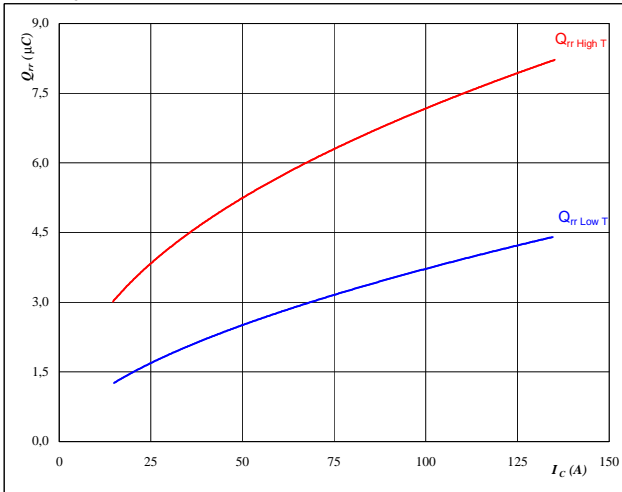


INPUT BOOST

Figure 13 BOOST FWD

Typical reverse recovery charge as a function of collector current

$Q_{rr} = f(I_C)$



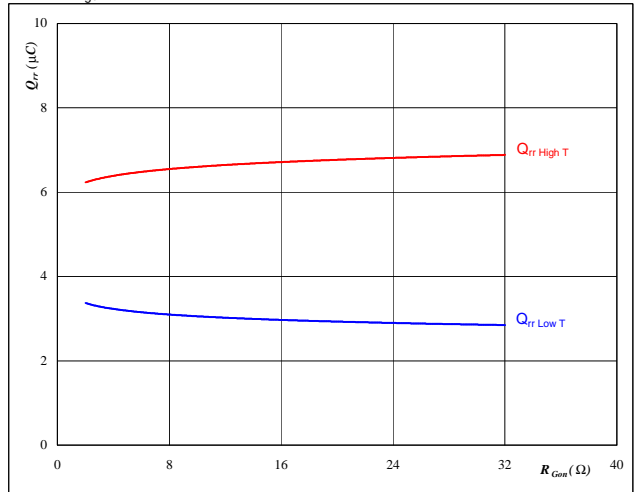
At

$T_j =$	25/150	°C
$V_{CE} =$	300	V
$V_{GE} =$	±15	V
$R_{gon} =$	8	Ω

Figure 14 BOOST FWD

Typical reverse recovery charge as a function of IGBT turn on gate resistor

$Q_{rr} = f(R_{gon})$



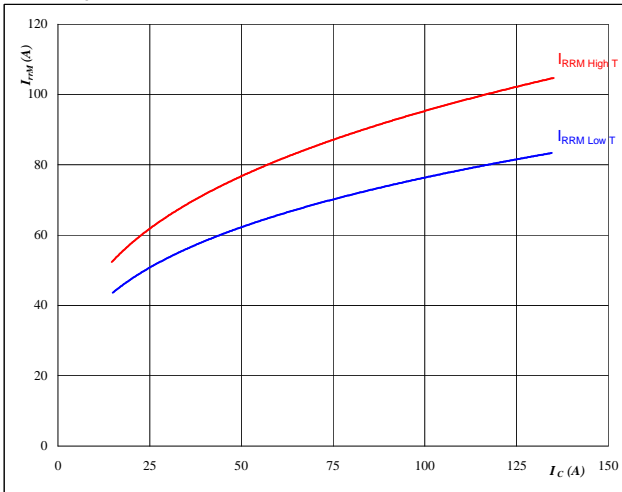
At

$T_j =$	25/150	°C
$V_R =$	300	V
$I_F =$	75	A
$V_{GE} =$	±15	V

Figure 15 BOOST FWD

Typical reverse recovery current as a function of collector current

$I_{RRM} = f(I_C)$



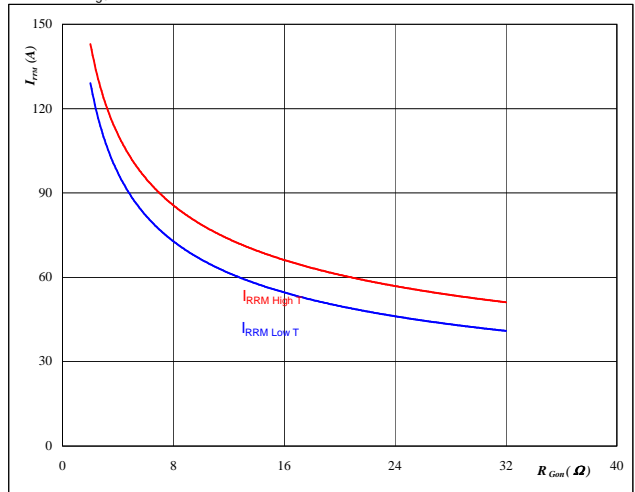
At

$T_j =$	25/150	°C
$V_{CE} =$	300	V
$V_{GE} =$	±15	V
$R_{gon} =$	8	Ω

Figure 16 BOOST FWD

Typical reverse recovery current as a function of IGBT turn on gate resistor

$I_{RRM} = f(R_{gon})$



At

$T_j =$	25/150	°C
$V_R =$	300	V
$I_F =$	75	A
$V_{GE} =$	±15	V

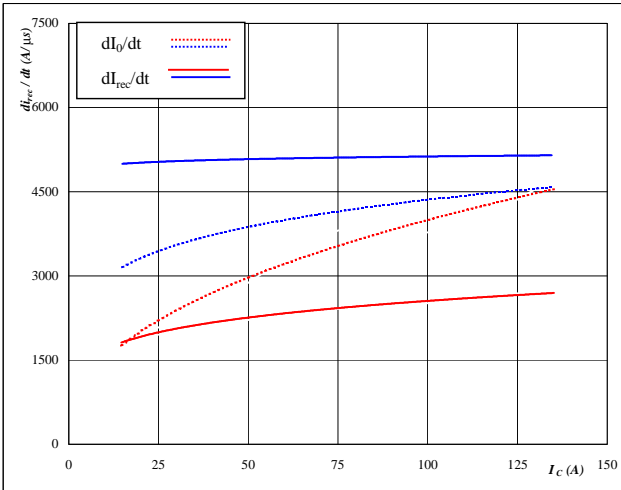


INPUT BOOST

Figure 17 BOOST FWD

Typical rate of fall of forward and reverse recovery current as a function of collector current

$dI_f/dt, dI_{rec}/dt = f(I_c)$

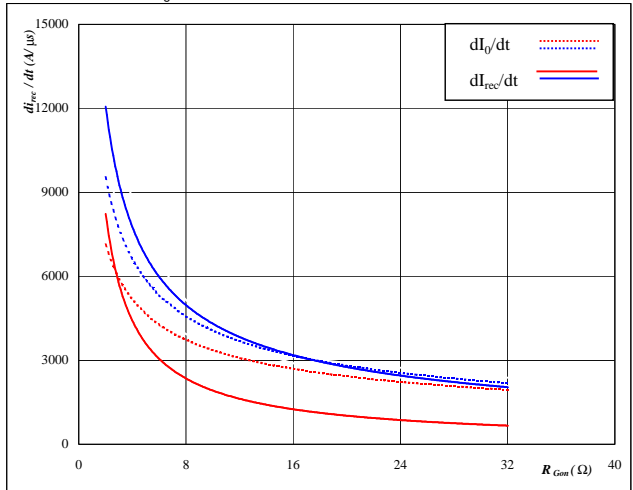


At
 T_j = 25/150 °C
 V_{CE} = 300 V
 V_{GE} = ±15 V
 R_{gon} = 8 Ω

Figure 18 BOOST FWD

Typical rate of fall of forward and reverse recovery current as a function of IGBT turn on gate resistor

$dI_f/dt, dI_{rec}/dt = f(R_{gon})$

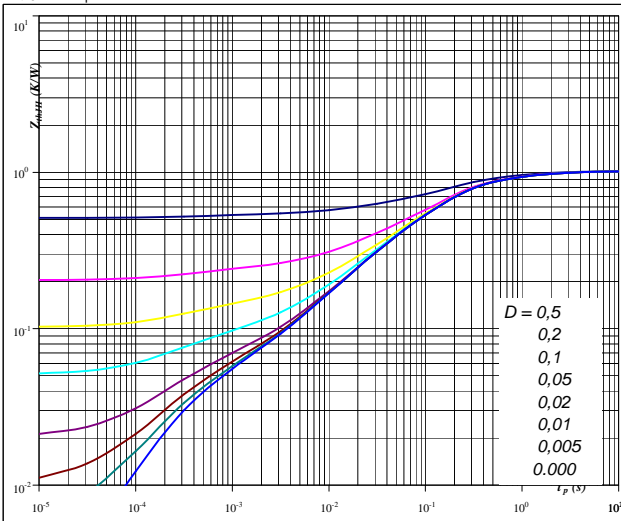


At
 T_j = 25/150 °C
 V_{GE} = 300 V
 I_F = 75 A
 V_{CE} = ±15 V

Figure 19 BOOST IGBT

IGBT transient thermal impedance as a function of pulse width

$Z_{thJH} = f(t_p)$



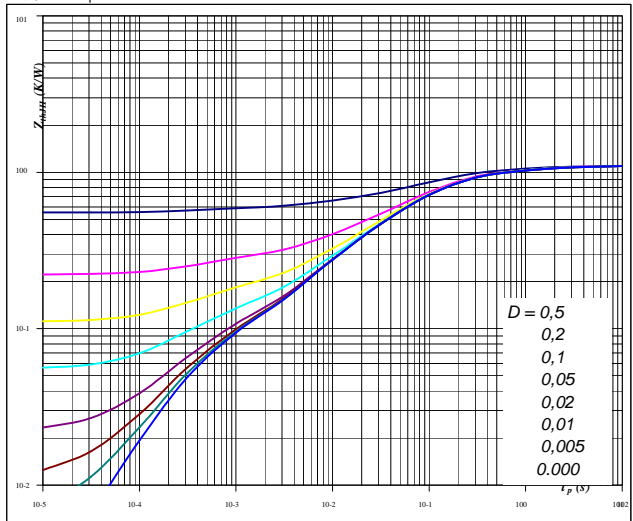
At
 D = t_p / T
 R_{thJH} = 1,02 K/W IGBT thermal model values

R (C/W)	Tau (s)
0,037	6,37E+00
0,176	8,57E-01
0,550	1,57E-01
0,179	2,60E-02
0,042	3,81E-03
0,037	3,09E-04

Figure 20 BOOST FWD

FWD transient thermal impedance as a function of pulse width

$Z_{thJH} = f(t_p)$



At
 D = t_p / T
 R_{thJH} = 1,11 K/W FWD thermal model values

R (C/W)	Tau (s)
0,03	9,19E+00
0,13	9,97E-01
0,43	1,49E-01
0,33	3,47E-02
0,12	5,94E-03
0,07	3,69E-04

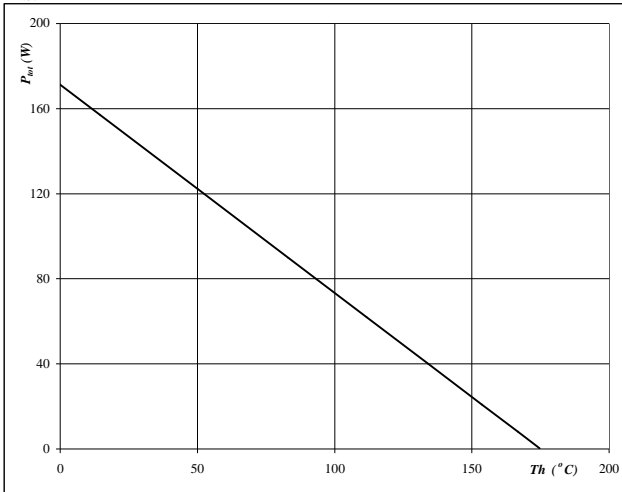


INPUT BOOST

Figure 21 BOOST IGBT

Power dissipation as a function of heatsink temperature

$P_{tot} = f(T_h)$

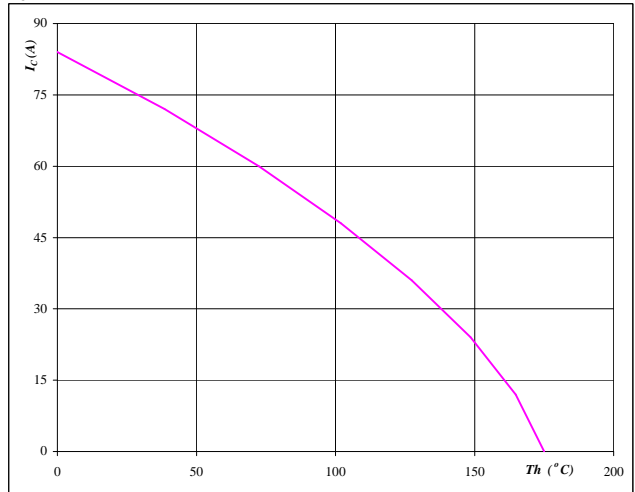


At
T_j = 175 °C

Figure 22 BOOST IGBT

Collector current as a function of heatsink temperature

$I_C = f(T_h)$

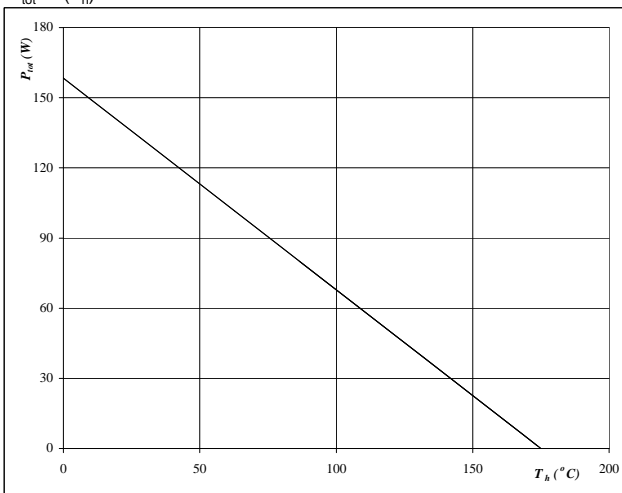


At
T_j = 175 °C
V_{GE} = 15 V

Figure 23 BOOST FWD

Power dissipation as a function of heatsink temperature

$P_{tot} = f(T_h)$

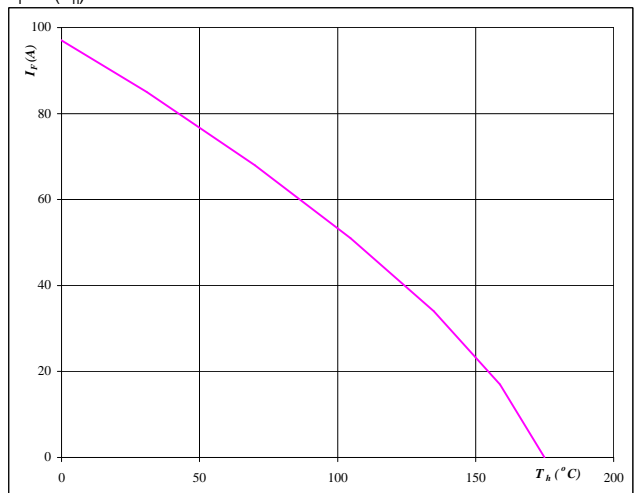


At
T_j = 175 °C

Figure 24 BOOST FWD

Forward current as a function of heatsink temperature

$I_F = f(T_h)$



At
T_j = 175 °C

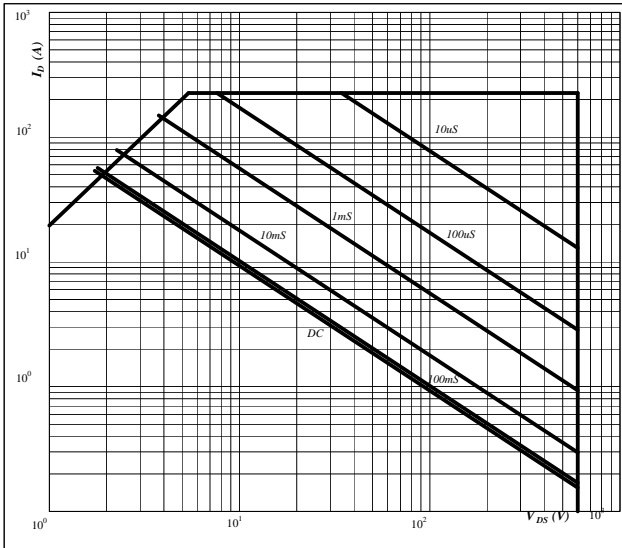


INPUT BOOST

Figure 25 BOOST IGBT

Safe operating area as a function of drain-source voltage

$I_C = f(V_{CE})$

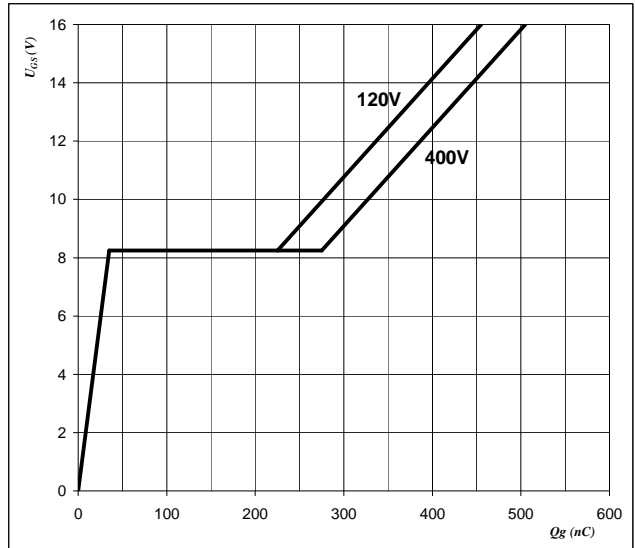


At
 D = single pulse
 $T_h = 80 \text{ } ^\circ\text{C}$
 $V_{GE} = \pm 15 \text{ V}$
 $T_j = T_{jmax} \text{ } ^\circ\text{C}$

Figure 26 BOOST IGBT

Gate voltage vs Gate charge

$V_{GE} = f(Q_g)$



At
 $I_C = 75 \text{ A}$

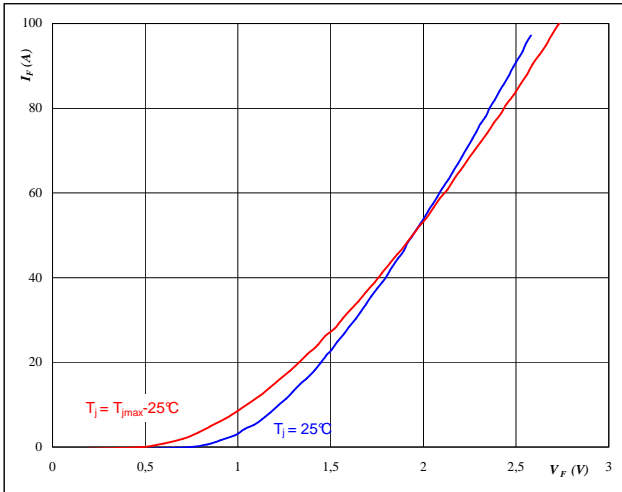


BOOST INV. DIODE

Figure 1 BOOST INV. DIODE

Typical diode forward current as a function of forward voltage

$I_F = f(V_F)$

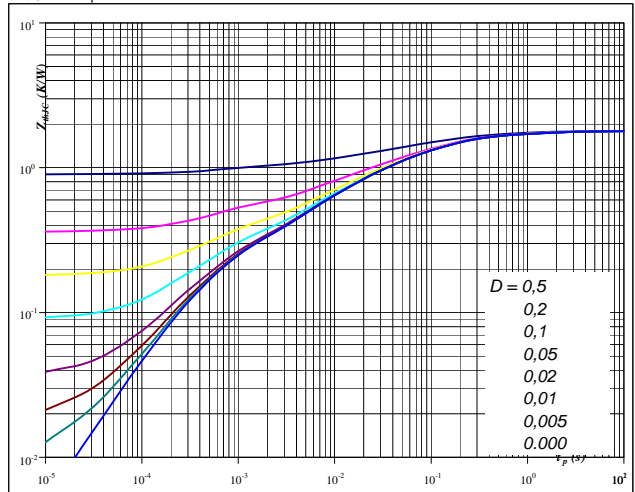


At $t_p = 250 \mu\text{s}$

Figure 2 BOOST INV. DIODE

Diode transient thermal impedance as a function of pulse width

$Z_{thJH} = f(t_p)$



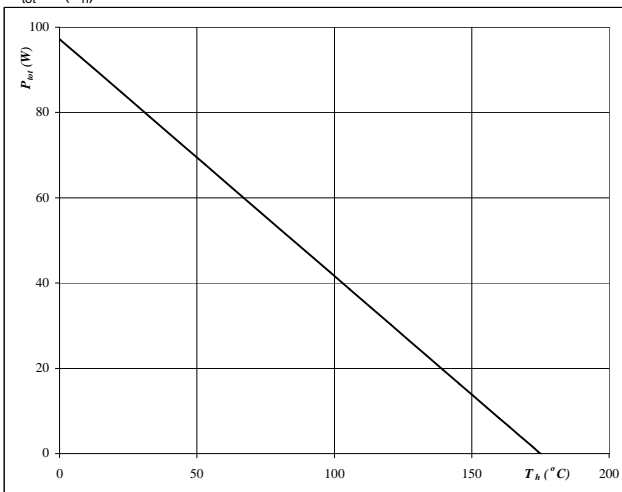
At $D = t_p / T$
 $R_{thJH} = 1,800 \text{ K/W}$

R (C/W)	Tau (s)
0,03771	8,99E+00
0,1799	8,31E-01
0,599	1,28E-01
0,4734	2,78E-02
0,3096	5,76E-03
0,2008	4,67E-04

Figure 3 BOOST INV. DIODE

Power dissipation as a function of heatsink temperature

$P_{tot} = f(T_h)$

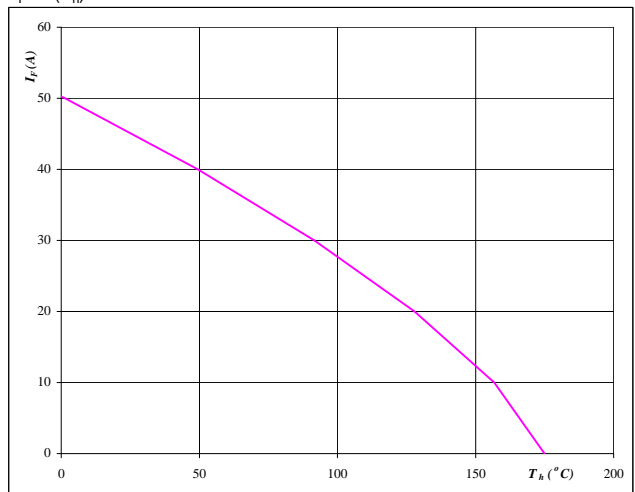


At $T_j = 175 \text{ }^\circ\text{C}$

Figure 4 BOOST INV. DIODE

Forward current as a function of heatsink temperature

$I_F = f(T_h)$



At $T_j = 175 \text{ }^\circ\text{C}$



Thermistor

Figure 1 Thermistor

Typical NTC characteristic as a function of temperature

$$R_T = f(T)$$

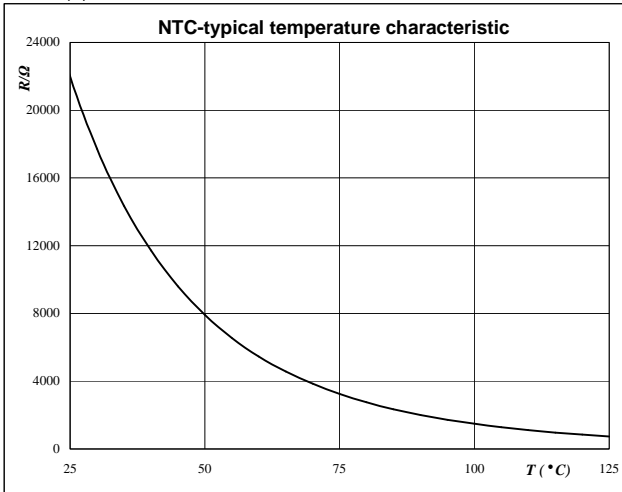


Figure 2 Thermistor

Typical NTC resistance values

$$R(T) = R_{25} \cdot e^{\left(B_{25/100} \left(\frac{1}{T} - \frac{1}{T_{25}} \right) \right)} \quad [\Omega]$$

T [°C]	R _{nom} [Ω]	R _{min} [Ω]	R _{max} [Ω]	ΔR/R [±%]
-55	2089434,5	1506495,4	2672373,6	27,9
0	71804,2	59724,4	83884	16,8
10	43780,4	37094,4	50466,5	15,3
20	27484,6	23684,6	31284,7	13,8
25	22000	19109,3	24890,7	13,1
30	17723,3	15512,2	19934,4	12,5
60	5467,9	4980,6	5955,1	8,9
70	3848,6	3546	4151,1	7,9
80	2757,7	2568,2	2947,1	6,9
90	2008,9	1889,7	2128,2	5,9
100	1486,1	1411,8	1560,4	5
150	400,2	364,8	435,7	8,8



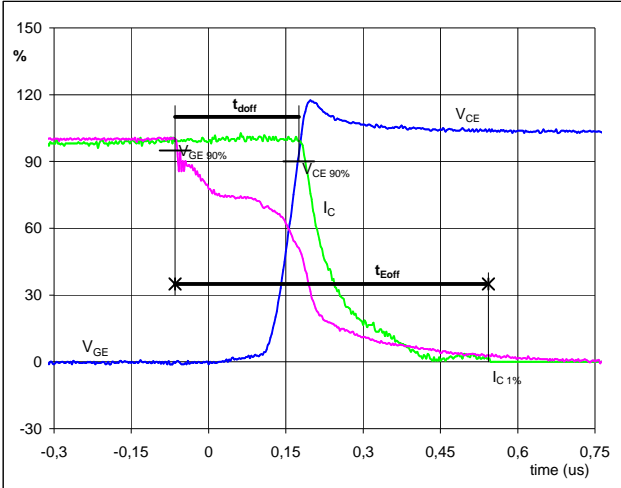
Switching Definitions Boost IGBT

General conditions

T_j	=	150 °C
R_{gon}	=	8 Ω
R_{goff}	=	8 Ω

Figure 1 BOOST IGBT

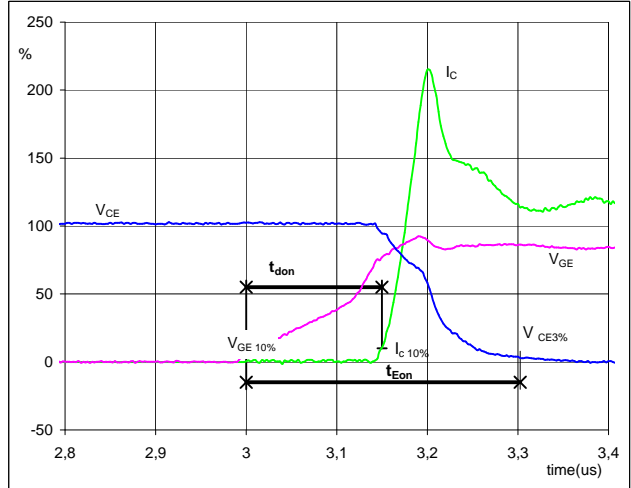
Turn-off Switching Waveforms & definition of t_{doff} , t_{Eoff}
 (t_{Eoff} = integrating time for E_{off})



V_{GE} (0%) =	-15	V
V_{GE} (100%) =	15	V
V_C (100%) =	300	V
I_C (100%) =	74	A
t_{doff} =	0,23	μs
t_{Eoff} =	0,61	μs

Figure 2 BOOST IGBT

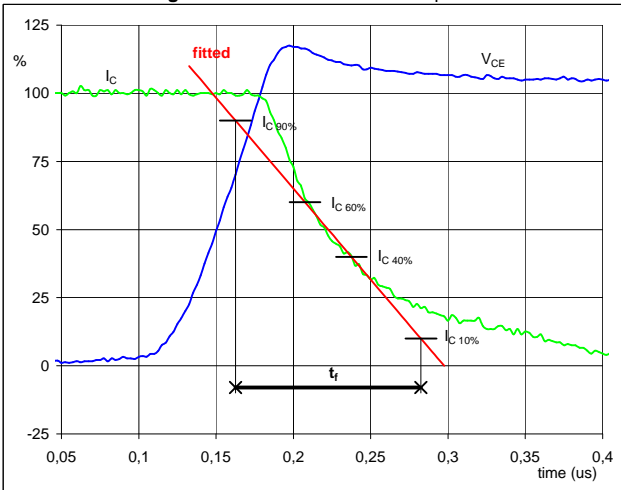
Turn-on Switching Waveforms & definition of t_{don} , t_{Eon}
 (t_{Eon} = integrating time for E_{on})



V_{GE} (0%) =	-15	V
V_{GE} (100%) =	15	V
V_C (100%) =	300	V
I_C (100%) =	74	A
t_{don} =	0,15	μs
t_{Eon} =	0,30	μs

Figure 3 BOOST IGBT

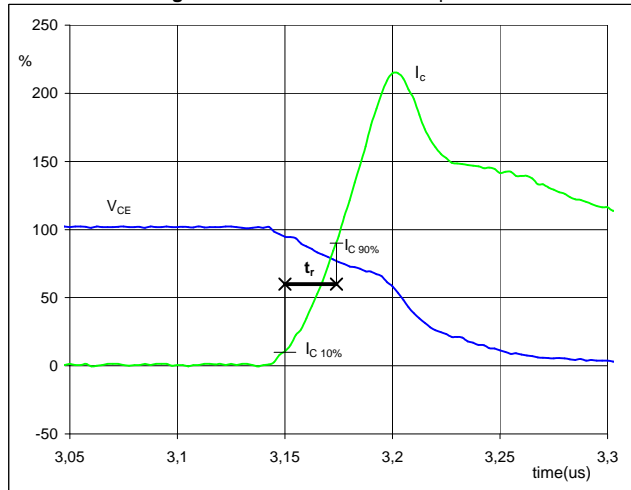
Turn-off Switching Waveforms & definition of t_f



V_C (100%) =	300	V
I_C (100%) =	74	A
t_f =	0,11	μs

Figure 4 BOOST IGBT

Turn-on Switching Waveforms & definition of t_r



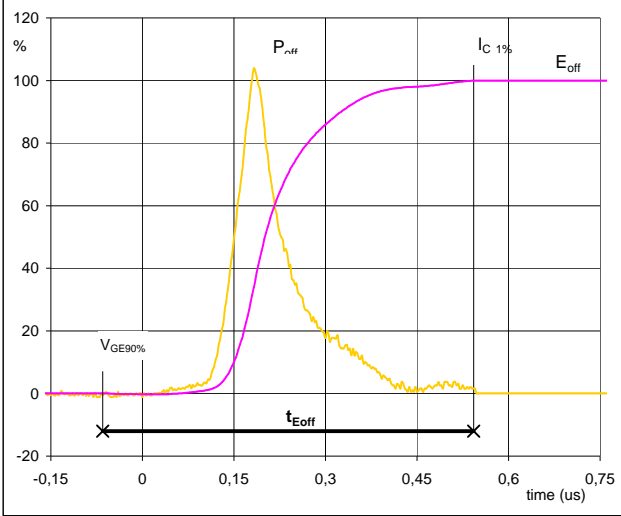
V_C (100%) =	300	V
I_C (100%) =	74	A
t_r =	0,02	μs



Switching Definitions Boost IGBT

Figure 5 BOOST IGBT

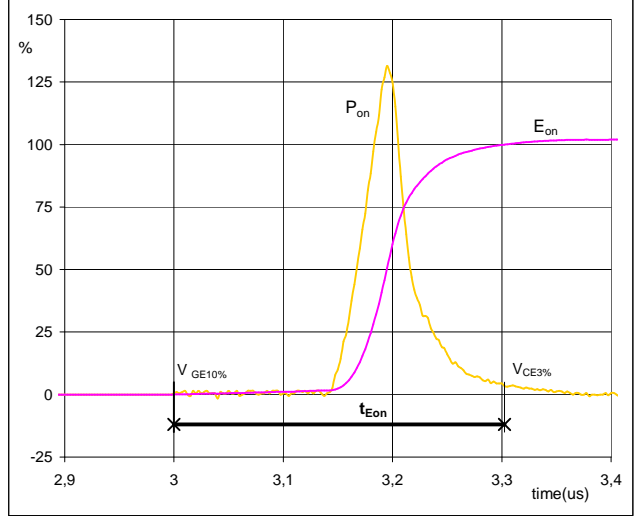
Turn-off Switching Waveforms & definition of t_{Eoff}



P_{off} (100%) =	22,30	kW
E_{off} (100%) =	2,41	mJ
t_{Eoff} =	0,61	μ s

Figure 6 BOOST IGBT

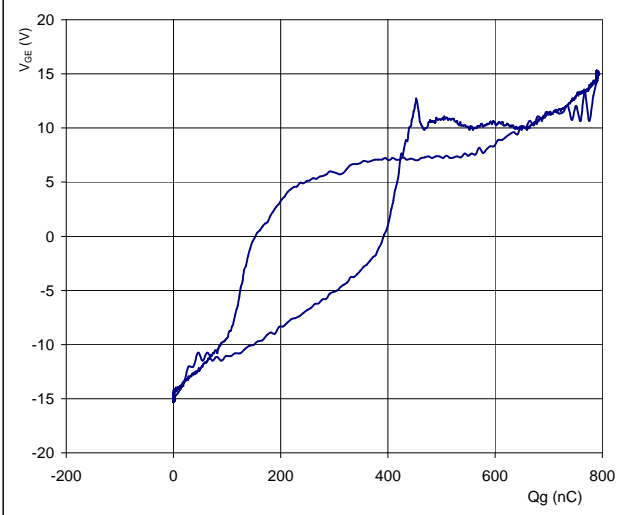
Turn-on Switching Waveforms & definition of t_{Eon}



P_{on} (100%) =	22,30	kW
E_{on} (100%) =	1,50	mJ
t_{Eon} =	0,30	μ s

Figure 7 BOOST IGBT

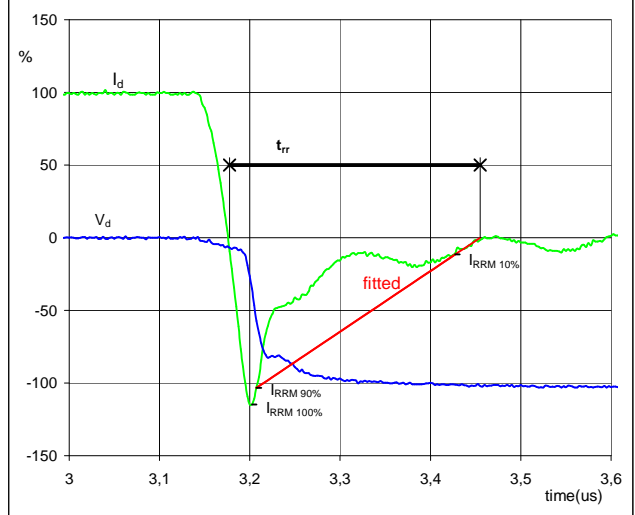
Gate voltage vs Gate charge (measured)



V_{GEoff} =	-15	V
V_{GEon} =	15	V
V_C (100%) =	300	V
I_C (100%) =	74	A
Q_g =	794,04	nC

Figure 8 BOOST FWD

Turn-off Switching Waveforms & definition of t_{rr}



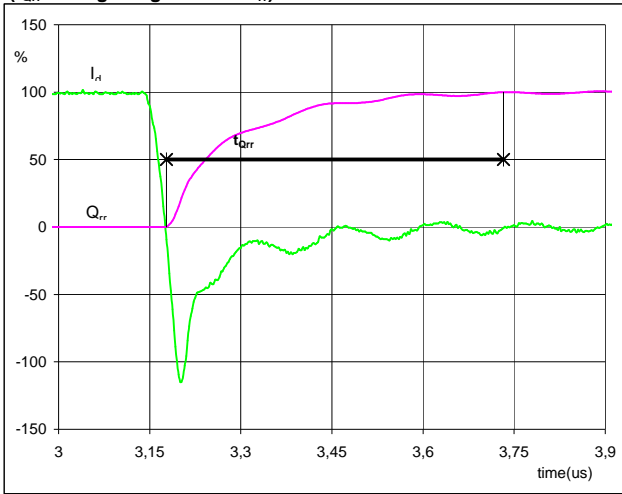
V_d (100%) =	300	V
I_d (100%) =	74	A
I_{RRM} (100%) =	-86	A
t_{rr} =	0,15	μ s



Switching Definitions Boost IGBT

Figure 9 BOOST FWD

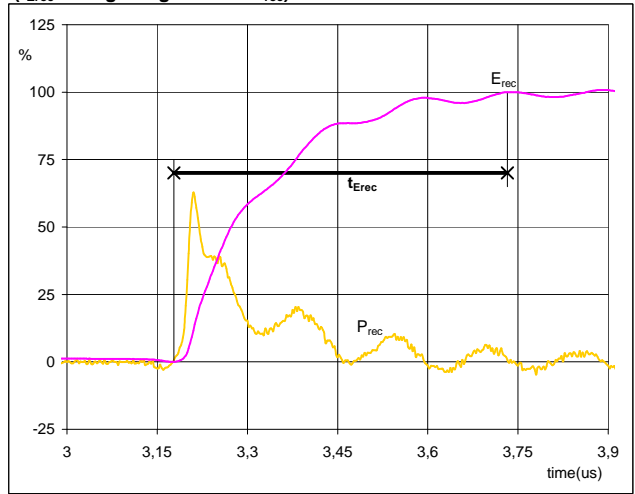
Turn-on Switching Waveforms & definition of t_{Qrr}
(t_{Qrr} = integrating time for Q_{rr})



I_d (100%) =	74	A
Q_{rr} (100%) =	6,19	μC
t_{Qrr} =	0,55	μs

Figure 10 BOOST FWD

Turn-on Switching Waveforms & definition of t_{Erec}
(t_{Erec} = integrating time for E_{rec})



P_{rec} (100%) =	22,30	kW
E_{rec} (100%) =	1,33	mJ
t_{Erec} =	0,55	μs



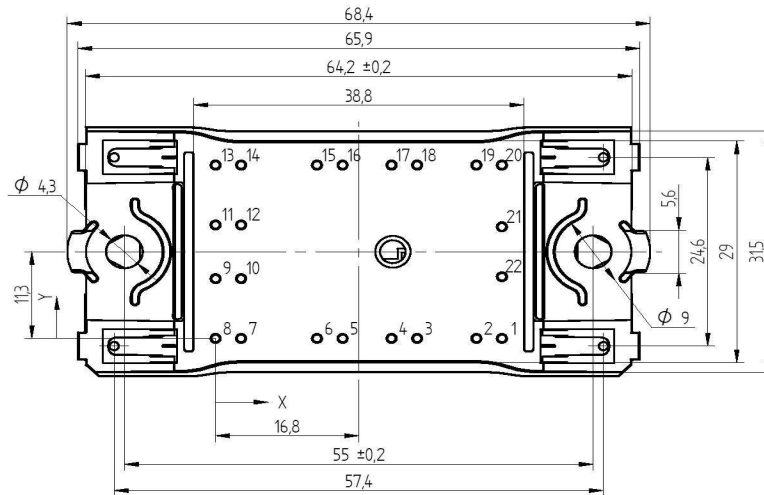
Ordering Code and Marking - Outline - Pinout

Ordering Code & Marking

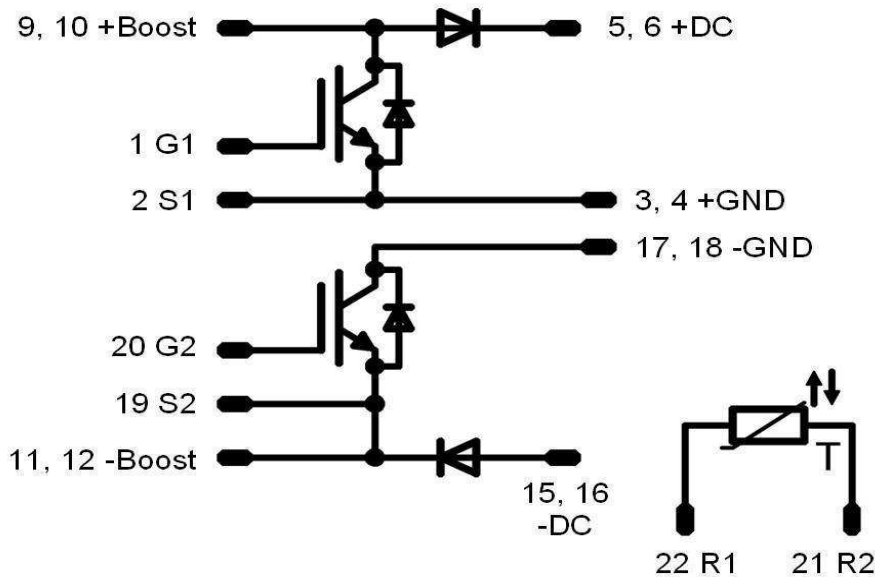
Version	Ordering Code	in DataMatrix as	in packaging barcode as
Standard in flow0 12mm housing	10-FZ06NBA075SA-P916L33	P916L33	P916L33

Outline

Pin table		
Pin	X	Y
1	33,6	0
2	30,6	0
3	23,65	0
4	20,65	0
5	14,9	0
6	11,9	0
7	3	0
8	0	0
9	0	7,8
10	3	7,8
11	0	14,8
12	3	14,8
13	0	22,6
14	3	22,6
15	11,9	22,6
16	14,9	22,6
17	20,65	22,6
18	23,65	22,6
19	30,6	22,6
20	33,6	22,6
21	33,6	14,55
22	33,6	8,05



Pinout



**PRODUCT STATUS DEFINITIONS**

Datasheet Status	Product Status	Definition
Target	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice. The data contained is exclusively intended for technically trained staff.
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Final	Full Production	This datasheet contains final specifications. Vincotech reserves the right to make changes at any time without notice in order to improve design. The data contained is exclusively intended for technically trained staff.

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